

Description

This invention relates to a tunable resistance device useful for implementing various analog signal processing functions and, especially, to a drain-biased transresistance device in an active continuous time filter which provides the filter with a tunable frequency response.

In particular this invention relates to a device comprising:

- first and second MOS transistors each having a drain electrode and a gate electrode,
- a differential amplifier having output means and first and second inputs coupled to the drain electrodes of the first and second transistors, respectively,
- a feedback circuit coupling said output means of said differential amplifier to at least one of the inputs of the differential amplifier. Such a device is known from pages 15-29 of an article in the IEEE Journal of Solid State Circuits, vol. SC-21, No.1, Feb. 1986 by Y. Tsvetkov et al entitled, "Continuous-Time MOSFET-C Filters in VLSI" or from US-A-4 710 726.

In the field of analog signal processing it is important to be able to monolithically generate RC time constants that are accurate, stable and controllable despite variations in process conditions and variations in temperature. The RC time constants determine crucial values such as timing delays and filter frequencies. Accurate RC time constants have been implemented monolithically in VLSI compatible switching technologies such as charge-coupled devices (CCD) and switched-capacitor filters by means of the controlled sampling and transfer of charge packages at a precise clock frequency (f_{ck}). In the switched-capacitor technique the resistance (R) is generated by data sampling and RC can be made to track a fixed clock frequency ($1/f_{ck}$). The switched-capacitor technique has become popular in the MOS analog signal processing field, especially in the development of monolithic filters. One reason for this is that the RC time constants of the basic filter building blocks, such as integrators, can be accurately controlled over varying process and temperatures ranges.

Unfortunately, in the switched-capacitor technique accuracy deteriorates rapidly as the signal frequency increases and approaches the clock frequency thereby limiting its utility in high frequency applications. The switched-capacitor technique suffers from a number of drawbacks including, for example, noise folding back into the baseband, the need for antialiasing and smoothing filters, charge injection by the switches, and the presence of switching noise. These drawbacks become more significant as the signal frequency is increased.

In the case of monolithic high frequency applications, continuous time techniques have been gaining in popularity because of the absence of switching problems. Continuous time techniques allow charges to flow continuously in a controlled manner onto a capacitor. The time it takes to charge up this capacitor is used to determine the time constant of the circuit. Two problems to be overcome in such techniques however, are the accurate reproducibility of the RC time constants, and the attainment of a large enough linear operating range so that the signal-to-noise ratio remains sufficiently large. The first of these problems can be solved by using a voltage-controlled active element to generate the R value. Automatic tuning of the RC value is then obtained by means of a phase-locked-loop where the phase of the signal from one such tunable element is compared with that of an external reference clock signal, generally a quartz crystal oscillator. Any difference in frequencies is smoothed out and used as a feedback signal to control the values of other tunable resistor elements. Time constants equal to multiples of the clock frequency can thus be generated. As for the second problem, attempts have been made to linearize the active element. However, the additional circuitry necessary to achieve reliable linearization generally deteriorates the high frequency performance of the circuit.

One solution to the problem of providing a linear tunable resistor element with good frequency performance is to use a MOS transistor as a voltage controlled resistor. By operating a pair of such transistors (M1 & M2) differentially the second order nonlinear terms in the integrator function can be cancelled. The gate voltage is used to tune or vary the value of R until the correct RC constant is achieved. Such an approach is described in the known device.

Although accurate and linear operation can be achieved with this last approach, several inherent limitations still exist. First, because both transistors M1 and M2 must remain in their triode regions at all times, the input signal voltage swing must be maintained at least one threshold voltage below the gate voltage. This severely limits the maximum allowable linear range (typically to about 1/3 of the supply voltage), making it necessary to use special pre-scaler and post-scaler circuits. Second, because the input signal is applied to the source-drain junction of the transistor, the input resistance is undesirably low. In an all MOS environment, it is typically difficult to design op-amps that are suitable for driving low resistive loads. Third, to use a PLL technique for automatic tuning typically requires significant chip area, involving such functional blocks as a tunable RC oscillator, a phase comparator and a large smoothing filter.

It is therefore an object of the invention to provide an electronically controlled resistance element as part of an RC building block especially suitable to provide various high frequency analog signal processing functions.

Another object of the invention is to use a non-linear MOS device in a novel manner so as to achieve a device with a wide range of continuous linear resistance (R).

A further object of the invention is to provide an electronically controllable MOS transistor device whose resistance R is variable in a continuous and linear manner over a wide dynamic range so as to provide good high frequency characteristics, direct on-chip tuning, high input impedance and good linearity over a wide input range.

A still further object of the invention is to provide a new method for generating accurate and controllable RC values for implementing various analog signal processing functions, e.g. filtering.

Another object of the invention is to provide a family of unique building blocks suitable for high frequency continuous time filters which exhibit a high input impedance to the applied signals.

A further object of the invention is to provide a high frequency continuous time filter that can be entirely integrated onto a single semiconductor chip.

Still another object of the invention is to provide an RC building block in which the value of RC automatically tracks clock frequency without the use of a phase-locked-loop.

According to the invention, a device of the type set forth in the preamble is characterized in that the device further comprises:

first and second adjustable bias current sources,

means connecting said first current source and said first transistor in series circuit across the terminals of a source of supply voltage and with the drain electrode of said first transistor connected to the first current source,

means connecting said second current source and said second transistor in series circuit across the terminals of the source of supply voltage and with the drain electrode of said second transistor connected to the second current source,

a pair of signal input terminals connected to respective gate electrodes of the first and second transistors, and

means for adjusting the value of bias currents supplied by the bias current sources to said first and second transistors thereby to bias the transistors into their triode regions, adjustment of said bias current sources being operative to vary the bias currents and thereby the drain voltages of the transistors so as to linearly vary the effective resistances of said transistors.

According to the invention the foregoing and other objects and advantages of the invention are achieved by means of a drain-biased transresistance MOS transistor device which makes use of the linear transresistance variation of a MOS transistor operated in the triode region. The input signal is applied to the gate of the MOS transistor and its effective resistance is tunable (adjustable) by controlling the transistor's drain voltage by means of an adjustable bias current applied thereto. The invention makes it possible to provide a family of elementary RC controllable devices suitable for various high frequency analog signal processing applications such as high frequency continuous time filter building blocks.

A preferred embodiment of the invention uses a pair of matched MOS transistors connected in a common source configuration and biased by two matched current sources coupled to respective drain electrodes of the pair of MOS transistors thereby to adjust the values of the drain voltages. The biasing of the drain voltages of the pair of matched MOS transistors into their triode regions provides a continuously variable linear resistance R created by the differential transresistance of the pair of MOS transistors. The drain voltages of the MOS transistors determine the resistance value R, which is controlled via a bias current (I_B) generated on the semiconductor chip by a bias current generator circuit. The bias current generator can be arranged so that the RC product is proportional to a clock frequency (e.g. $1/f_{ck}$).

The invention thus provides a new drain-biased transresistance (DBT) device as an elementary building block for a wide variety of high frequency analog signal processing devices, such as VLSI-compatible continuous time analog filters (e.g. antialiasing filters or smoothing filters) modulator/demodulator in data transmission apparatus and as a stereo decoder in an audio system. In general, a DBT filter can be used in applications that presently use switched-capacitor filters, e.g. speech analysis and synthesis, mobile transceivers, radar and sonar devices, orthogonal transforms, automatic inspection systems etc.

The novel DBT devices to be described provide good RC controllability and high frequency response, a large linear input range (about 2/3 of the supply voltage in one experimental device), high input impedance, ease of tuning, integration of entire video signal processing functions onto a single chip to cut costs and increase reliability, and the ability to make RC track $1/f_{ck}$ without using a phase-locked-loop.

The invention will now be described in greater detail by reference to the accompanying drawings in which: Figure 1 shows a single-ended version of a DBT element which illustrates the basic concept of the invention,

Figure 2 shows a differential version of a DBT tunable element which can be used as a basic building block

for RC filters or the like,

Figure 3 shows a basic gate-input continuous RC integrator using a tunable DBT element,

Figure 4 shows a differential embodiment of a DBT fixed gain amplifier,

Figure 5 shows a DBT inverting damped integrator,

5 Figure 6 shows a DBT system which provides automatic tuning for a plurality of tunable DBT-RC elements, and

Figure 7 shows a second order tunable DBT filter.

Figure 1 illustrates the basic elementary DBT tunable RC element suitable for use as the basic building block in high frequency continuous time filters and other high frequency analog signal processing devices. The circuit of Fig. 1 shows a single-ended version of the basic DBT element. It consists of a matched pair of MOS transistors M1 and M2 connected in a common source configuration. First and second matched current sources I_B are connected in series with the transistors M1 and M2, respectively, between a source of DC supply voltage V_{DD} and a common ground connection. The current sources set the drain voltages of transistors M1 and M2 to a voltage value VX. The value of bias current I_B is adjusted so that the transistors M1 and M2 operate deep into the triode region thus ensuring a large linear operating range.

15 The source 1 of input signal (V_{in}) is coupled to the respective gate electrodes of MOS transistors M1 and M2. A quiescent voltage VCM, typically approximately $V_{DD}/2$, is applied to each gate electrode from a terminal 2. The drain electrode of transistor M1 is connected to the inverting input (-) of an op-amp 3 and the drain electrode of transistor M2 is connected to the non-inverting input (+) of the op-amp. A feedback circuit 4 couples the output of the op-amp to its inverting input. The relationship between the current I_B and the voltage VX can be shown to be

$$I_B = \beta [(V_{CM} - V_{th}) VX - 1/2 VX^2] \quad (1)$$

where β and V_{th} are the gain factor and threshold voltage of the MOS transistors.

When an input signal V_{in} from the voltage source 1 is added to VCM into the gate of transistor M1, a current that is greater than I_B is forced to flow through transistor M1. Since the op-amp will maintain the same voltage across its two input terminals, the current that flows through transistor M1 becomes

$$I_{M1} = \beta [(V_{in} + V_{CM} - V_{th}) VX - 1/2 VX^2] \quad (2)$$

The current difference ΔI between the currents I_{M1} and I_B must flow directly out of the feedback element 4 and is given by

$$30 \quad \Delta I = I_{M1} - I_B = \beta V_{in} VX \quad (3)$$

Equation (3) shows that there is a direct linear relationship between ΔI and V_{in} and this condition will be satisfied so long as transistors M1 and M2 remain in the triode region. The effective resistance R of this circuit is thus

$$35 \quad R = \frac{V_{in}}{\Delta I} = \frac{1}{\beta VX} \quad (4)$$

The resistance R can be electrically adjusted by changing the value of VX, where VX is controlled by the bias current I_B in accordance with equation (1).

The single-ended DBT element of Fig. 1 is made fully differential by applying a negative signal component to the gate of transistor M2 and by having dual feedback paths from the outputs of a fully differential op-amp.

40 Fig. 2 shows a basic variable resistance DBT element in which the resistance value R is developed differentially by means of the linear transconductances of a matched pair of MOS transistors M1 and M2 again connected in a common source configuration and biased by respective first and second adjustable constant current sources consisting of p-channel transistors M3 and M4. Transistors M3 and M4 are connected in series with transistors M1 and M2, respectively, between the source of DC supply voltage V_{DD} and ground.

45 A fixed common-mode voltage V_{CM} is applied to the gate electrodes of transistors M1 and M2 along with the input signal V_{in} . The magnitude of the bias current I_B is controlled by a common source of bias voltage V_B applied to the gate electrodes of transistors M3 and M4 from a terminal 5. A feedback circuit 6 couples first and second output terminals of the differential op-amp 7 to respective input terminals (+) and (-) thereof. The feedback circuit 6 maintains the voltages VX at the drain electrodes of transistors M1 and M2 equal. The output signal voltage V_o is taken across output terminals 8, 9.

50 The drain voltages VX are determined by the product of the bias currents I_B and the on resistances of the transistors M1 and M2 and is kept sufficiently small so that transistors M1 and M2 will both remain in their triode regions even when a large differential input voltage is applied to the input gate electrodes. This feature makes it possible to achieve a large linear range of operation.

55 A simple analysis of the circuit of Fig. 2 will demonstrate the linearity of its transfer function. If a differential signal V_{in} is applied to the gate electrodes of the transistors M1 and M2, the gate voltages of M1 and M2 are then $V_{CM} + V_{in}/2$ and $V_{CM} - V_{in}/2$, respectively. The drain currents in the transistors M1 and M2 then become

$$I_{M1} = \beta \left[\left(\frac{V_{id}}{2} + V_{CM} - V_{th} \right) V_X - \frac{1}{2} V_X^2 \right] \quad (5)$$

$$I_{M2} = \beta \left[\left(-\frac{V_{id}}{2} + V_{CM} - V_{th} \right) V_X - \frac{1}{2} V_X^2 \right] \quad (6)$$

5 where β and V_{th} are the gain factor and threshold voltages of the devices. By subtracting the two currents, the square term dependence on V_X is cancelled. This results in a linear relationship between ΔI , given by $I_{M1} - I_{M2}$, and V_{id} :

$$\Delta I = \beta V_{id} V_X \quad (7)$$

10 A differential current ΔI is forced to flow into the two feedback components. This forces a differential output voltage equal to the product of ΔI and the impedance of the feedback circuit 6. The effective transresistance of this circuit from the input gate voltage to the output drain current is given by

$$R = \frac{V_{id}}{\Delta I} = \frac{1}{\beta V_X} \quad (8)$$

15 The value of R can thus be tuned by modifying the value of V_X and I_B . Equation (8) is valid even for large signals as long as transistors M1 and M2 remain in their triode regions.

By modifying the feedback element 6, different generic functions can be developed. Monolithic analog filters can be synthesized from a number of generic building blocks such as integrators, fixed gain amplifiers, and damped integrators. Each of these building blocks can be realized with the DBT element of Fig. 2 by using appropriate feedback components.

20 A fully differential embodiment of a negative integrator is shown in Fig. 3. The inverting RC integrator of Fig. 3 is achieved by modifying the feedback circuit of Fig. 2 so as to provide first and second capacitive feedback paths from the outputs of op-amp 7 via respective capacitors 10, 11 to the non-inverting (+) and the inverting (-) inputs, respectively. The differential current from M1 and M2 is forced into the feedback capacitors 10, 11 via the feedback action of the op-amp. The output of the integrator then becomes:

$$V_O = - \frac{1}{C_f} \int \Delta I \, dt = - \frac{\beta V_X}{C_f} \int V_{id} \, dt \quad (9)$$

30 where C_f is the capacitance of capacitors 10 and 11 and V_{id} is the input differential voltage applied between the gate electrodes of transistors M1 and M2. The effective RC time constant of this integrator is given by

$$\tau = \frac{C_f}{\beta V_X} \quad (10)$$

35 With the proper V_B bias, achieved through automatic tuning techniques, the time constant can be made invariant to processing and temperature variations.

40 The magnitude of the bias currents I_B will be sufficient to force both M1 and M2 deep into their triode regions. When a differential input signal (with a common mode voltage V_{CM}) is applied to the gates of transistors M1 and M2, then the relationships of equations (5) - (8) also apply to the circuit of Fig. 3. The value of R in equation (8) is then valid even for large signals.

45 Fig. 4 illustrates another basic building block, a DBT fixed gain amplifier. This fixed gain inverting amplifier is realized by substituting a further pair of drain-biased MOS transistors M1F and M2F as feedback components in place of the feedback capacitors of the DBT integrator of Fig. 3. The feedback transistor M1F is connected in parallel with transistor M1 and the feedback transistor M2F is connected in parallel with transistor M2. The amplifier circuit of Fig. 4 is otherwise similar to the integrator circuit of Fig. 3.

Any ΔI current forced by the pair of input transistors M1 and M2 will now be compensated by the pair of feedback transistors M1F and M2F so that where

$$\Delta I_i = \Delta I_f \quad (11)$$

50 where ΔI_i and ΔI_f are currents associated with the input and feedback transistor pairs, respectively. From equations (7) and (11) the following relationship between V_{id} and V_o is valid

$$\beta_i V_{id} V_X = - \beta_f V_o V_X \quad (12)$$

or

$$\frac{V_o}{V_{id}} = - \frac{\beta_i}{\beta_f} \quad (13)$$

55 Equation (13) shows that the circuit provides a constant gain even for large signals. In order to keep the value of V_X invariant from block to block, the presence of the feedback devices M1F and M2F must be compensated by an appropriate increase in bias current I_B . This is achieved by increasing the W/L ratio of the current sources

M3 and M4.

A circuit for implementing a DBT damped integrator is shown in Fig. 5. An inverting damped integrator is produced by means of a combination of the feedback elements of the devices shown in Figs. 3 and 4. Thus, the DBT damped integrator of Fig. 5 includes the feedback capacitors 10, 11, each with a capacitance value C_f of Fig. 3 in combination with the parallel arranged feedback transistors M1F and M2F of Fig. 4. The transfer function of this basic circuit can be shown to be

$$\frac{V_O}{V_{id}} = - \frac{\beta_i}{\beta_f} \left[\frac{1}{1 + \frac{s C_f}{\beta_f V_X}} \right] \quad (14)$$

Being fully differential, any of the three above described inverting building blocks can be changed into a non-inverting equivalent building block by simply interchanging or reversing the two differential output nodes. The six basic DBT building blocks thus constitute a family of tunable elements which can be used to implement various monolithic analog filters, as well as other high frequency analog signal processing functions.

Good frequency performance is achieved from the above building blocks. In each case, the presence of the op-amp forces a virtual ground condition to exist between the drain of M1 and M2. This effectively removes the only possible high impedance node from the signal path, thus preventing any Miller multiplication effects from degrading the frequency response.

In order to demonstrate the functionality of the DBT technique, a single-ended version of the DBT fixed-gain amplifier and the DBT integrator were built using standard components. The single-ended version is functionally equivalent to the differential version except that second order non-linearities are not cancelled as effectively. The DBT single-ended fixed gain amplifier was tested and experimental waveforms were measured at the input and output of an amplifier with a gain of -1. Using a 10 volt supply, V_{CM} was set at 5 V and the linear range of the output signal was over 6V, or roughly 2/3 of the supply voltage. The lower and upper limits of the measured linear range were determined by the points at which the transistors M1 and M1F (Fig. 4) came out of their respective triode regions. A very slight curvature in the output waveform was detected, which translates into less than 10% non-linearity at both extremes.

This curvature in the waveform exists only in the output of the single-ended DBT amplifier and is attributed to the difference in gate voltages between transistors M1 and M1F. The different gate voltages cause different degrees of mobility degradation in β_i and β_f , thus altering the β_i/β_f ratio of equation (13). In a fully differential circuit, this source of error would not be significant since the same nonlinearity would appear at both outputs of the circuit, and would cancel each other when the output is taken differentially.

In the case of a square wave input, the output waveform of the DBT integrator was again linear over at least a 6V swing. By varying only the bias voltage V_B , the RC time constant of the circuit was adjusted to give varying heights to the triangular output wave. The value of the drain voltage V_X was adjusted to values of 0.2V, 0.35V, and 0.5 V. The experimental results achieved were very good.

The classical approach for achieving automatic tuning is to use a phase-locked loop (PLL). A source of clock voltage with a fixed frequency (f_{ext}) is applied to a first input of a phase comparator. The output of the phase comparator is applied to the input of a smoothing filter at whose output a common bias voltage (V_B) is developed for all of the tunable RC elements on a semiconductor chip. The bias voltage V_B is also applied as a control input voltage to control the frequency of an RC oscillator, which can also be realized using a DBT element. The output voltage of the oscillator at a frequency f_o is applied to a second input of the phase comparator. When the feedback loop consisting of the phase comparator, the smoothing filter and the RC oscillator achieves equilibrium, then f_o is equal to f_{ext} and all of the RC values of the RC elements on the chip are proportional to $1/f_{ext}$. Since f_{ext} is precisely controlled, all of the RC values are accurate. One drawback of the PLL technique is that it requires the conversion of the output of the phase comparator to a near DC value for V_B . This places a high demand on the smoothing filter used in the PLL automatic tuning method.

A new automatic tuning circuit shown in Fig. 6 provides an alternate method for automatic tuning that avoids the need for phase comparison and filtering, thus making it possible to use a smaller chip area than is possible with the PLL approach. The RC time constants of all of the DBT elements on the semiconductor chip are controlled simultaneously by means of a common bias voltage V_B .

The bias voltage generator in Fig. 6 includes first and second integrators, 12 and 13, respectively. Each integrator has one input that is connected to an external clock source via an input terminal 14. The external clock source has a period T_{ext} . Each of the integrators has a second input connected to a respective current source 15, 16 which supplies a current I_k , which need not be precise. The integrators also include capacitors

17, 18 each of a capacitance value C_k . The outputs of the integrators are connected via a switching device 19 to the gate electrodes of MOS transistors $M1_k$ and $M2_k$, which are part of a DBT stage.

Transistors $M1_k$ and $M2_k$ are connected in series with MOS transistors $M3_k$ and $M4_k$, respectively, between a source of supply voltage and ground. A current source 20 supplies a current I_k to the drain of transistor $M1_k$.
 5 The drain electrodes of transistors $M1_k$ and $M2_k$ are connected to the non-inverting (+) and inverting (-) inputs, respectively, of an op-amp 21. The output of the op-amp provides the bias voltage V_B to the various other tunable DBT RC elements 22, 23 etc., which controls the bias currents I_B of each of these RC elements. The output voltage V_B is also coupled to the gate electrodes of transistors $M3_k$ and $M4_k$ to control the bias currents and thereby the drain voltages (VX) of the transistors $M1_k$ and $M2_k$.

10 The two integrators alternately charge and discharge the capacitors to provide continuous operation, thereby avoiding the need for a smoothing filter. Each integrator functions to charge up its respective capacitor 17, 18 via its respective current source 15, 16. During the period T_{ext} of the external clock source (not shown) coupled to terminal 14, the capacitor 17 or 18 of capacitance C_k charges to a potential V_k , where

$$15 \quad V_k = \left(\frac{I_k}{C_k} \right) T_{ext} \quad (15)$$

If V_k is applied to the differential inputs of the DBT element $M1_k - M4_k$, the differential current between transistors $M1_k$ and $M2_k$ would be :

$$\Delta I = \beta_k V_k V_X \quad (16)$$

If a current I_k is forced into the drain of $M1_k$, under closed loop conditions, ΔI would equal I_k . Thus

$$20 \quad I_k = \Delta I = \beta_k V_k V_X \quad (17)$$

Substituting equation (15) into (17) yields

$$I_k = \beta_k T_{ext} \frac{I_k}{C_k} V_X \quad (18)$$

which can be simplified to

$$25 \quad \frac{I}{V_X} = \frac{\beta_k T_{ext}}{C_k} \quad (19)$$

which is the necessary condition for equilibrium when a bias current I_B , determined by the op-amp's output V_B , is flowing into transistor $M2_k$. Once the value of V_B is found such that the condition of equation (19) is satisfied, the voltage V_B can be used as a common bias for all of the other DBT elements 22, 23 etc. Each of the time
 30 constants can be found by substituting equation (19) into the time constant (τ) equation (10) of each RC block. This results in

$$\tau = \frac{C_r}{\beta V_X} = \left(\frac{\beta_k}{\beta} \right) \left(\frac{C_r}{C_k} \right) T_{ext} \quad (20)$$

35 Note that each value of τ is now the product of two β ratios, two C ratios, and T_{ext} . Since parameter ratios can usually be controlled quite precisely, and if T_{ext} is a stable, controllable parameter, then all of the time constants in a filter will be stable and controllable.

Fig. 7 shows a second order tunable bandpass/low pass elliptic filter. This is only one example of many filters that can be realized by combining a plurality of tunable DBT elements in accordance with the invention.
 40 The filter comprises two differential op-amps 24, 25, four DBT elements 26-29, and four capacitors 30-33. Each op-amp contains a local feedback circuit that sets the output common mode voltage to V_{CM} . The nominal band edge frequency of this filter is set at 20KHz. By adjusting the bias voltage V_B , this frequency can be made to vary from about 10KHz to 40KHz. Bandpass and low pass responses are obtained from the outputs 34 (V_{OBP}) and 35 (V_{OLP}) respectively. For a supply voltage $V_{DD} = 8V$, a linear range close to 2/3 of the supply voltage can be achieved without any pre-scaling. And because this circuit is fully differential, the effective signal range
 45 can be as large as 10V.

It will be clear from the above description that the DBT device in accordance with the invention provides numerous advantages and unique features which will make it possible to generate accurate and controlled RC values in order to implement various high frequency analog signal processing functions, especially, but not
 50 limited to, high frequency continuous time analog filters.

Claims

- 55 1. A device comprising:
 first (M1) and second (M2) MOS transistors each having a drain electrode and a gate electrode,
 a differential amplifier (3) having output means and first and second inputs coupled to the drain
 electrodes of the first (M1) and second (M2) transistors, respectively,

a feedback circuit (4) coupling said output means of said differential amplifier (3) to at least one of the inputs of the differential amplifier (3), characterized in that the device further comprises:

first and second adjustable bias current sources (IB),

means connecting said first current source and said first transistor (M1) in series circuit across the terminals of a source of supply voltage (V_{DD}) and with the drain electrode of said first transistor (M1) connected to the first current source,

means connecting said second current source and said second transistor (M2) in series circuit across the terminals of the source of supply voltage (V_{DD}) and with the drain electrode of said second transistor (M2) connected to the second current source,

a pair of signal input terminals connected to respective gate electrodes of the first (M1) and second (M2) transistors, and

means for adjusting the value of bias currents supplied by the bias current sources (IB) to said first (M1) and second (M2) transistors thereby to bias the transistors into their triode regions, adjustment of said bias current sources being operative to vary the bias currents and thereby the drain voltages of the transistors so as to linearly vary the effective resistances of said transistors.

2. A device as claimed in Claim 1 wherein said first (M1) and second (M2) transistors are matched MOS transistors and said first and second current sources comprise third (M3) and fourth (M4) matched MOS transistors having their gate electrodes connected in common to a terminal for a source of adjustable bias voltage (V_B).

3. A device as claimed in Claim 2 wherein said differential amplifier output means includes first and second output terminals connected to first and second input terminals of the feedback circuit (6), wherein the feedback circuit (6) comprises first and second output terminals coupled to said first and second inputs, respectively, of the differential amplifier (7), and wherein said device comprises first (8) and second (9) output terminals connected to the first and second output terminals of the differential amplifier (7).

4. A device as claimed in Claim 3 the feedback circuit (6) further comprising:
first (10) and second (11) feedback capacitors each with a capacitance C_f ,
means connecting the first capacitor (10) between the first input terminal of the feedback circuit (6) and the first output terminal thereof and the second capacitor (11) between the second input terminal of the feedback circuit (6) and the second output terminal thereof, the feedback capacitors (10, 11) forming in combination with the resistance of the first (M1) and second (M2) transistors an integrator device.

5. A device as claimed in Claim 4 wherein the circuit parameters are arranged so that the effective RC time constant (τ) of the integrator device is:

$$\tau = \frac{C_f}{\beta V_X}$$

where β is the transistor gain factor and V_X the drain voltages of the first and second transistors.

6. A device as claimed in Claim 2 further comprising:
a fifth MOS transistor (M1F) connected in parallel with the first MOS transistor (M1),
a sixth MOS transistor (M2F) connected in parallel with the second MOS transistor (M2),
means connecting first and second output terminals of the differential amplifier (7) to respective gate electrodes of the fifth (M1F) and sixth (M2F) transistors,
first and second output terminals connected to the first and second output terminals of the differential amplifier.

7. A device as claimed in Claim 6 wherein the device circuit parameters are arranged so that :

$$\frac{V_O}{V_{in}} = - \frac{\beta_1}{\beta_f}$$

where V_O is the output signal voltage, across the first and second output terminals of the device V_{in} is the input signal voltage across the pair of signal input terminals of the device, β_1 is the gain factor of the first (M1) and second (M2) transistors and β_f is the gain factor of the fifth (M1F) and sixth (M2F) transistors.

8. A device as claimed in Claim 6 or 7 further comprising:
first (10) and second (11) feedback capacitors, and
means connecting the first capacitor (10) between the first output terminal of the differential am-

plifier (7) and the first input thereof and the second capacitor (11) between the second output terminal of the differential amplifier (7) and the second input thereof.

9. An automatic tuning system for one or more turnable RC elements (22, 23) comprising:
- first (12) and second (13) devices each as claimed in Claim 4 wherein the gate electrode of at least the first transistor (M1) of each device is connected to a terminal (14) that receives a clock signal,
 - fifth (M1K) and sixth (M2K) matched MOS transistors each having a drain electrode and a gate electrode,
 - seventh (M3K) and eighth (M4K) matched MOS transistors each having a gate electrode,
 - means connecting said fifth (M1K) and seventh (M3K) transistors in series circuit across terminals of a source of supply voltage with the drain electrode of the fifth (M1K) transistor forming a common junction with an electrode of the seventh transistor (M3K),
 - means connecting said sixth (M2K) and eighth (M4K) transistors in series circuit across the terminals of the source of supply voltage with the drain electrode of the sixth (M2K) transistor forming a common junction with an electrode of the eighth transistor (M4K),
 - switching means (19) coupling the gate electrodes of the fifth (M1K) and sixth (M2K) transistors to the outputs of the first (12) and second (13) devices,
 - a further differential amplifier (21) having first and second inputs connected to the drain electrodes of the fifth (M1K) and sixth (M2K) transistors, respectively, and
 - means connecting an output of said further differential amplifier (21) to the gate electrodes of the seventh (M3K) and eighth (M4K) transistors and to a bias voltage input terminal of said one or more tunable RC elements (22, 23) thereby to adjust the RC time constant of the RC element and bias currents of the fifth (M1K) and sixth (M2K) transistors.
10. A tunable filter comprising:
- first (26), second (28), third (29) and fourth (27) devices each as claimed in Claim 2 with each device having first and second output terminals connected to first and second output terminals of its respective differential amplifier,
 - first (24) and second (25) op-amps each having first and second input terminals, first and second output terminals, and first and second capacitors (30, 31, 32, 33) connected between its respective first input and output terminals and its second input and output terminals, respectively,
 - means connecting said first device (26) and said first op-amp (24) in cascade between a pair of signal input terminals (V_{id}) and a pair of filter output terminals (34),
 - means coupling the second device (28) in a feedback circuit between the first and second output terminals of the first op-amp (24) and the first and second input terminals thereof,
 - means coupling the third device (29) and the second op-amp (25) in cascade between said pair of filter output terminals (34) and a second pair of filter output terminals (35), and
 - means coupling said fourth device (27) between said second pair of filter output terminals (35) and the first and second output terminals of the first device (26).

Patentansprüche

1. Vorrichtung, die folgendes enthält:
- einen ersten (M1) und einen zweiten (M2) MOS-Transistor, wobei jeder eine Drain-Elektrode und eine Gate-Elektrode aufweist;
 - einen Differentialverstärker (3) mit Ausgangsmitteln und einem ersten und einem zweiten Eingang, die mit den Drain-Elektroden des ersten (M1) bzw. des zweiten (M2) Transistors verbunden sind;
 - eine Rückkopplungsschaltung (4), die die genannten Ausgangsmittel des genannten Differentialverstärkers (3) mit mindestens einem der Eingänge des Differentialverstärkers (3) verbindet, dadurch gekennzeichnet, daß die Vorrichtung weiterhin folgendes enthält:
 - eine erste und eine zweite einstellbare Vorstromquelle (IB);
 - Mittel, die die genannte erste Stromquelle und den genannten ersten Transistor (M1) in Reihenschaltung zu den Anschlüssen einer Versorgungsspannungsquelle (V_{DD}) parallel schalten, wobei die Drain-Elektrode des genannten ersten Transistors (M1) mit der ersten Stromquelle verbunden ist;
 - Mittel, die die genannte zweite Stromquelle und den genannten zweiten Transistor (M2) in Reihenschaltung zu den Anschlüssen der Versorgungsspannungsquelle (V_{DD}) parallel schalten, wobei die Drain-Elektrode des genannten zweiten Transistors (M2) mit der zweiten Stromquelle verbunden ist;



plifier (7) and the first input thereof and the second capacitor (11) between the second output terminal of the differential amplifier (7) and the second input thereof.

9. An automatic tuning system for one or more turnable RC elements (22, 23) comprising:
- first (12) and second (13) devices each as claimed in Claim 4 wherein the gate electrode of at least the first transistor (M1) of each device is connected to a terminal (14) that receives a clock signal,
 - fifth (M1K) and sixth (M2K) matched MOS transistors each having a drain electrode and a gate electrode,
 - seventh (M3K) and eighth (M4K) matched MOS transistors each having a gate electrode,
 - means connecting said fifth (M1K) and seventh (M3K) transistors in series circuit across terminals of a source of supply voltage with the drain electrode of the fifth (M1K) transistor forming a common junction with an electrode of the seventh transistor (M3K),
 - means connecting said sixth (M2K) and eighth (M4K) transistors in series circuit across the terminals of the source of supply voltage with the drain electrode of the sixth (M2K) transistor forming a common junction with an electrode of the eighth transistor (M4K),
 - switching means (19) coupling the gate electrodes of the fifth (M1K) and sixth (M2K) transistors to the outputs of the first (12) and second (13) devices,
 - a further differential amplifier (21) having first and second inputs connected to the drain electrodes of the fifth (M1K) and sixth (M2K) transistors, respectively, and
 - means connecting an output of said further differential amplifier (21) to the gate electrodes of the seventh (M3K) and eighth (M4K) transistors and to a bias voltage input terminal of said one or more tunable RC elements (22, 23) thereby to adjust the RC time constant of the RC element and bias currents of the fifth (M1K) and sixth (M2K) transistors.
10. A tunable filter comprising:
- first (26), second (28), third (29) and fourth (27) devices each as claimed in Claim 2 with each device having first and second output terminals connected to first and second output terminals of its respective differential amplifier,
 - first (24) and second (25) op-amps each having first and second input terminals, first and second output terminals, and first and second capacitors (30, 31, 32, 33) connected between its respective first input and output terminals and its second input and output terminals, respectively,
 - means connecting said first device (26) and said first op-amp (24) in cascade between a pair of signal input terminals (V_{in}) and a pair of filter output terminals (34),
 - means coupling the second device (28) in a feedback circuit between the first and second output terminals of the first op-amp (24) and the first and second input terminals thereof,
 - means coupling the third device (29) and the second op-amp (25) in cascade between said pair of filter output terminals (34) and a second pair of filter output terminals (35), and
 - means coupling said fourth device (27) between said second pair of filter output terminals (35) and the first and second output terminals of the first device (26).

Patentansprüche

1. Vorrichtung, die folgendes enthält:
- einen ersten (M1) und einen zweiten (M2) MOS-Transistor, wobei jeder eine Drain-Elektrode und eine Gate-Elektrode aufweist;
 - einen Differentialverstärker (3) mit Ausgangsmitteln und einem ersten und einem zweiten Eingang, die mit den Drain-Elektroden des ersten (M1) bzw. des zweiten (M2) Transistors verbunden sind;
 - eine Rückkopplungsschaltung (4), die die genannten Ausgangsmittel des genannten Differentialverstärkers (3) mit mindestens einem der Eingänge des Differentialverstärkers (3) verbindet, dadurch gekennzeichnet, daß die Vorrichtung weiterhin folgendes enthält:
 - eine erste und eine zweite einstellbare Vorstromquelle (IB);
 - Mittel, die die genannte erste Stromquelle und den genannten ersten Transistor (M1) in Reihenschaltung zu den Anschlüssen einer Versorgungsspannungsquelle (V_{DD}) parallelschalten, wobei die Drain-Elektrode des genannten ersten Transistors (M1) mit der ersten Stromquelle verbunden ist;
 - Mittel, die die genannte zweite Stromquelle und den genannten zweiten Transistor (M2) in Reihenschaltung zu den Anschlüssen der Versorgungsspannungsquelle (V_{DD}) parallelschalten, wobei die Drain-Elektrode des genannten zweiten Transistors (M2) mit der zweiten Stromquelle verbunden ist;



ein Paar Signaleingangsanschlüsse, die mit den entsprechenden Gate-Elektroden des ersten (M1) und des zweiten Transistors (M2) verbunden sind;

Mittel zum Einstellen des Wertes der von den Vorstromquellen an die genannten ersten (M1) und zweiten (M2) Transistoren gelieferten Vorströme (IB), um die Transistoren so vorzuspannen, daß sie in ihrem Triodenbereich arbeiten, wobei die Einstellung der genannten Vorstromquellen dazu dient, die Vorströme und somit die Drain-Spannungen der Transistoren so zu variieren, daß die Wirkwiderstände der genannten Transistoren linear variieren.

2. Vorrichtung nach Anspruch 1, wobei der genannte erste (M1) und der genannte zweite (M2) Transistor aufeinander abgestimmte MOS-Transistoren sind und die genannten ersten und zweiten Stromquellen dritte (M3) und vierte (M4) aufeinander abgestimmte MOS-Transistoren enthält, deren Gate-Elektroden gemeinsam mit einem Anschluß für eine Quelle einstellbarer Vorspannung (V_B) verbunden sind.

3. Vorrichtung nach Anspruch 2, wobei die genannten Ausgangsmittel des differentiellen Verstärkers erste und zweite Ausgangsanschlüsse enthalten, die mit den ersten und zweiten Eingangsanschlüssen des Rückkopplungskreises (6) verbunden sind, wobei der Rückkopplungskreis (6) erste und zweite Ausgangsanschlüsse enthält, die mit den genannten ersten bzw. zweiten Eingängen des differentiellen Verstärkers (7) verbunden sind, und wobei die genannte Vorrichtung erste (8) und zweite (9) Ausgangsanschlüsse enthält, die mit den ersten und zweiten Ausgangsanschlüssen des differentiellen Verstärkers (7) verbunden sind.

4. Vorrichtung nach Anspruch 3, wobei der Rückkopplungskreis (6) außerdem folgendes beinhaltet: erste (10) und zweite (11) Rückkopplungskondensatoren, jeder mit einer Kapazität C_f ;
Mittel zum Anschließen des ersten Kondensators (10) zwischen dem ersten Eingangsanschluß des Rückkopplungskreises (6) und dessen erstem Ausgangsanschluß und zum Anschließen des zweiten Kondensators (11) zwischen dem zweiten Eingangsanschluß des Rückkopplungskreises (6) und dessen zweitem Ausgangsanschluß, wobei die Rückkopplungskondensatoren (10, 11) in Kombination mit dem Widerstand des ersten (M1) und des zweiten (M2) Transistors eine Integrator-Vorrichtung bilden.

5. Vorrichtung nach Anspruch 4, wobei die Schaltungsparameter so ausgelegt sind, daß die wirksame RC-Zeitkonstante (τ) der Integrator-Vorrichtung

$$\tau = \frac{C_f}{\beta V_X}$$

entspricht, wobei β der Verstärkungsfaktor des Transistors und V_X die Drain-Spannungen des ersten und zweiten Transistors bezeichnet.

6. Vorrichtung nach Anspruch 2, die außerdem folgendes enthält:
einen fünften MOS-Transistor (M1F), der mit dem ersten MOS-Transistor (M1) parallelgeschaltet ist;

einen sechsten MOS-Transistor (M2F), der mit dem zweiten MOS-Transistor (M2) parallelgeschaltet ist;

Mittel zum Verbinden des ersten und des zweiten Ausgangsanschlusses des differentiellen Verstärkers (7) mit den entsprechenden Gate-Elektroden des fünften (M1F) und des sechsten (M2F) Transistors;

einen ersten und einen zweiten Ausgangsanschluß, die mit dem ersten und mit dem zweiten Ausgangsanschluß des differentiellen Verstärkers verbunden sind.

7. Vorrichtung nach Anspruch 6, wobei die Schaltungsparameter der Vorrichtung folgendermaßen aussehen:

$$\frac{V_O}{V_{id}} = - \frac{\beta_1}{\beta_2}$$

wobei V_O die Ausgangssignalspannung zwischen dem ersten und dem zweiten Ausgangsanschluß der Vorrichtung und V_{id} die Eingangssignalspannung zwischen den beiden Eingangsanschlüssen der Vorrichtung, β_1 die Verstärkung des ersten (M1) und des zweiten (M2) Transistors und β_2 die Verstärkung des fünften (M1F) und sechsten (M2F) Verstärkers darstellt.

8. Vorrichtung nach Anspruch 6 oder 7, die weiterhin folgendes beinhaltet:
einen ersten (10) und einen zweiten (11) Rückkopplungskondensator, und
Mittel zum Anschließen des ersten Kondensators (10) zwischen dem ersten Ausgangsanschluß



des differentiellen Verstärkers (7) und dessem ersten Eingang und zum Anschließen des zweiten Kondensators (11) zwischen dem zweiten Ausgangsanschluß des differentiellen Verstärkers (7) und dessem zweiten Eingang.

- 5 9. Automatisches Abstimmssystem für ein oder mehrer abstimbare RC-Elemente (22, 23), das folgendes enthält:
- erste (12) und zweite (13) Vorrichtungen jeweils nach Anspruch 4, wobei die Gate-Elektrode von mindestens dem ersten Transistor (M1) jeder Vorrichtung mit einem Anschluß (14) verbunden ist, der ein Taktsignal empfängt;
- 10 fünfte (M1K) und sechste (M2K) aufeinander abgestimmte MOS-Transistoren, die jeder eine Drain-Elektrode und eine Gate-Elektrode haben;
- siebte (M3K) und achte (M4K) aufeinander abgestimmte MOS-Transistoren, die jeder eine Gate-Elektrode haben;
- Mittel zum Parallelschalten der genannten fünften (M1K) und siebten (M3K) Transistoren in Reihenschaltung mit den Anschlüssen einer Versorgungsspannungsquelle, wobei die Drain-Elektrode des fünften (M1K) Transistors einen gemeinsamen Verbindungspunkt mit einer Elektrode des siebten Transistors (M3K) bildet;
- 15 Mittel zum Parallelschalten der genannten sechsten (M2K) und achten (M4K) Transistoren in Reihenschaltung mit den Anschlüssen der Versorgungsspannungsquelle, wobei die Drain-Elektrode des sechsten (M2K) Transistors einen gemeinsamen Verbindungspunkt mit einer Elektrode des achten Transistors (M4K) bildet;
- 20 Schaltmittel (19), die die Gate-Elektroden des fünften (M1K) und des sechsten (M2K) Transistors mit den Ausgängen der ersten (12) und der zweiten (13) Vorrichtung verbinden;
- einen weiteren differentiellen Verstärker (21), dessen erster und zweiter Eingang mit den Drain-Elektroden des fünften (M1K) bzw. des sechsten (M2K) Transistors verbunden sind; und
- 25 Mittel zum Verbinden eines Ausgangs des genannten weiteren differentiellen Verstärkers (21) mit den Gate-Elektroden des siebten (M3K) und des achten (M4K) Transistors und mit einem Vorspannungseingangsanschluß des genannten einen oder mehrerer abstimmbaren RC-Elemente (22, 23), um dadurch die RC-Zeitkonstante des RC-Elements und die Vorströme des fünften (M1K) und des sechsten (M2K) Transistors einzustellen.
- 30 10. Abstimmbarer Filter, der folgendes enthält:
- erste (26), zweite (28), dritte (29) und vierte (27) Vorrichtungen jeweils nach Anspruch 2, wobei jede Vorrichtung einen ersten und einen zweiten Ausgangsanschluß besitzt, die mit dem ersten und dem zweiten Ausgangsanschluß ihres entsprechenden differentiellen Verstärkers verbunden sind;
- 35 einen ersten (24) und einen zweiten (25) Operationsverstärker, die jeder einen ersten und einen zweiten Eingangsanschluß, einen ersten und einen zweiten Ausgangsanschluß und einen ersten und einen zweiten Kondensator (30, 31, 32, 33) haben, die zwischen ihren entsprechenden ersten Eingangs- und Ausgangsanschlüssen bzw. ihren zweiten Eingangs- und Ausgangsanschlüssen geschaltet sind;
- 40 Mittel zum Anschließen der genannten ersten Vorrichtung (26) und des genannten ersten Operationsverstärkers (24) in Kaskadenschaltung zwischen zwei Signal-Eingangsanschlüssen (V_{id}) und zwei Filter-Ausgangsanschlüssen (34);
- Mittel zum Verbinden der zweiten Vorrichtung (28) in einem Rückkopplungskreis zwischen dem ersten und dem zweiten Ausgangsanschluß des ersten Operationsverstärkers (24) und dessem ersten und zweiten Eingangsanschluß;
- 45 Mittel zum Anschließen der dritten Vorrichtung (29) und des zweiten Operationsverstärkers (25) in Kaskadenschaltung zwischen den genannten zwei Filter-Ausgangsanschlüssen (34) und zwei weiteren Filter-Ausgangsanschlüssen (35); und
- Mittel zum Anschließen der genannten vierten Vorrichtung (27) zwischen den genannten zwei weiteren Filter-Ausgangsanschlüssen (35) und den ersten und zweiten Ausgangsanschlüssen der ersten Vorrichtung (26).
- 50

Revendications

- 55 1. Dispositif comprenant:
- un premier (M1) et un second (M2) transistors MOS ayant chacun une électrode de drain et une électrode de grille,



un amplificateur différentiel (3) ayant une sortie et une première et une seconde entrées couplées respectivement aux électrodes de drain des premier (M1) et second (M2) transistors,

un circuit de rétroaction (4) couplant ladite sortie dudit amplificateur différentiel (3) à au moins une des entrées de l'amplificateur différentiel (3), caractérisé en ce que le dispositif comprend en plus :

une première et une seconde sources de courant de polarisation réglable (IB),

un moyen de connecter ladite première source de courant et ledit premier transistor (M1) en un circuit série via les bornes d'une source de tension d'alimentation (V_{DD}) et l'électrode de drain dudit premier transistor (M1) étant connectée à la première source de courant,

un moyen de connecter ladite seconde source de courant et ledit second transistor (M2) en un circuit série via les bornes de la source de tension d'alimentation (V_{DD}) et l'électrode de drain dudit second transistor (M2) étant connectée à la seconde source de courant,

une paire de bornes d'entrée de signal connectées aux électrodes de grille respectives des premier (M1) et second (M2) transistors, et

un moyen d'ajustement de la valeur des courants de polarisation fournis par les sources de courants de polarisation (IB) auxdits premier (M1) et second (M2) transistors afin de polariser de la sorte les transistors dans leurs régions de fonctionnement en triode, l'ajustement desdites sources de courant de polarisation fonctionnant de façon à faire varier les courants de polarisation et ainsi les tensions de drain des transistors de manière à faire varier linéairement les résistances effectives desdits transistors.

2. Dispositif suivant la revendication 1, dans lequel lesdits premier (M1) et second (M2) transistors sont des transistors MOS appariés et lesdites première et seconde sources de courant comprennent un troisième (M3) et un quatrième (M4) transistors MOS appariés ayant leurs électrodes de grille connectées en commun à une borne pour une source de tension de polarisation ajustable (V_B).

3. Dispositif suivant la revendication 2, dans lequel la sortie dudit amplificateur différentiel comprend une première et une seconde bornes de sortie connectées aux première et seconde bornes d'entrée du circuit de rétroaction (6), dans lequel le circuit de rétroaction (6) comprend une première et une seconde bornes de sortie couplées respectivement auxdites première et seconde entrées de l'amplificateur différentiel (7), et dans lequel ledit dispositif comprend une première (8) et une seconde (9) bornes de sortie connectées aux première et seconde bornes de sortie de l'amplificateur différentiel (7).

4. Dispositif suivant la revendication 3, le circuit de rétroaction (6) comprenant en plus :
un premier (10) et un second (11) condensateurs de rétroaction, de capacité C_r chacun,
un moyen pour connecter le premier condensateur (10) entre la première borne d'entrée du circuit de rétroaction (6) et la première borne de sortie de celui-ci et le second condensateur (11) entre la seconde borne d'entrée du circuit de rétroaction (6) et la seconde borne de sortie de celui-ci, les condensateurs de rétroaction (10, 11) formant en combinaison avec la résistance des premier (M1) et second (M2) transistors un dispositif intégrateur.

5. Dispositif suivant la revendication 4, dans lequel les paramètres du circuit sont arrangés de telle manière que la constante de temps RC effective (τ) du dispositif intégrateur est :

$$\tau = \frac{C_r}{\beta V_X}$$

où β est le facteur de gain du transistor et V_X représente les tensions de drain des premier et second transistors.

6. Dispositif suivant la revendication 2, comprenant en plus :
un cinquième transistor MOS (M1F) connecté en parallèle avec le premier transistor MOS (M1),
un sixième transistor MOS (M2F) connecté en parallèle avec le second transistor MOS (M2),
un moyen de connecter les première et seconde bornes de sortie de l'amplificateur différentiel (7) aux électrodes de grille respectives des cinquième (M1F) et sixième (M2F) transistors,
une première et une seconde bornes de sortie connectées aux première et seconde bornes de sortie de l'amplificateur différentiel.

7. Dispositif suivant la revendication 6, dans lequel les paramètres de circuit du dispositif sont tels que :

$$\frac{V_O}{V_{id}} = - \frac{\beta_1}{\beta_2}$$

où V_O est la tension du signal de sortie entre les première et seconde bornes de sortie du dispositif, V_{id}



est la tension du signal d'entrée entre la paire de bornes d'entrée de signal du dispositif, β_1 est le facteur de gain des premier (M1) et second (M2) transistors et β_r est le facteur de gain des cinquième (M1F) et sixième (M2F) transistors.

- 5 8. Dispositif suivant la revendication 6 ou 7, comprenant en plus :
 - un premier (10) et un second (11) condensateurs de rétroaction, et
 - un moyen de connecter le premier condensateur (10) entre la première borne de sortie de l'amplificateur différentiel (7) et la première entrée de celui-ci et le second condensateur (11) entre la seconde borne de sortie de l'amplificateur différentiel (7) et la seconde entrée de celui-ci.
- 10 9. Système d'ajustement automatique pour un ou plusieurs éléments RC ajustables (22, 23) comprenant :
 - un premier (12) et un second (13) dispositifs, chacun suivant la revendication 4, dans lesquels l'électrode de grille d'au moins le premier transistor (M1) de chaque dispositif est connectée à une borne (14) qui reçoit un signal d'horloge,
 - 15 un cinquième (M1K) et un sixième (M2K) transistors MOS appariés ayant chacun une électrode de drain et une électrode de grille,
 - un septième (M3K) et un huitième (M4K) transistors MOS appariés ayant chacun une électrode de grille,
 - un moyen de connecter lesdits cinquième (M1K) et septième (M3K) transistors en un circuit série entre les bornes d'une source de tension d'alimentation, l'électrode de drain du cinquième transistor (M1K) formant une jonction commune avec une électrode du septième transistor (M3K),
 - 20 un moyen de connecter lesdits sixième (M2K) et huitième (M4K) transistors en un circuit série entre les bornes d'une source de tension d'alimentation, l'électrode de drain du sixième transistor (M2K) formant une jonction commune avec une électrode du huitième transistor (M4K),
 - 25 un moyen de commutation (19) couplant les électrodes de grille des cinquième (M1K) et sixième (M2K) transistors aux sorties des premier (12) et second (13) dispositifs,
 - un amplificateur différentiel supplémentaire (21) ayant une première et une seconde entrées connectées respectivement aux électrodes de drain des cinquième (M1K) et sixième (M2K) transistors, et
 - 30 un moyen de connecter une sortie dudit amplificateur différentiel supplémentaire (21) aux électrodes de grille des septième (M3K) et huitième (M4K) transistors et à une borne d'entrée d'une tension de polarisation desdits un ou plusieurs éléments RC ajustables (22, 23) afin d'ajuster la constante de temps RC de l'élément RC et les courants de polarisation des cinquième (M1K) et sixième (M2K) transistors.
- 35 10. Filtre ajustable comprenant :
 - un premier (26), second (28), troisième (29) et quatrième (27) dispositifs, chacun suivant la revendication 2, chaque dispositif ayant une première et une seconde bornes de sortie connectées aux première et seconde bornes de sortie de son amplificateur différentiel respectif,
 - 40 un premier (24) et un second (25) amplificateurs opérationnels ayant chacun une première et une seconde bornes d'entrée, une première et une seconde bornes de sortie, et un premier et un second condensateurs (30, 31, 32, 33) connectés respectivement entre ses premières bornes d'entrée et de sortie respectives et ses secondes bornes d'entrée et de sortie respectives,
 - un moyen de connecter ledit premier dispositif (26) et ledit premier amplificateur opérationnel (24) en cascade entre une paire de bornes d'entrée de signal (V_{id}) et une paire de bornes de sortie de filtre (34),
 - 45 un moyen de coupler le second dispositif (28) en un circuit de rétroaction entre les première et seconde bornes de sortie du premier amplificateur opérationnel (24) et les première et seconde bornes d'entrée de celui-ci,
 - 50 un moyen de coupler le troisième dispositif (29) et le second amplificateur opérationnel (25) en cascade entre ladite paire de bornes de sortie de filtre (34) et une seconde paire de bornes de sortie de filtre (35), et
 - un moyen de coupler ledit quatrième dispositif (27) entre ladite seconde paire de bornes de sortie de filtre (35) et les première et seconde bornes de sortie du premier dispositif (26).